Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/044,441	GONZALEZ ET AL.	
Examiner	Art Unit	
Brad Y. Chin	1744	

SEARCHED						
Class	Subclass	Date	Examiner			
422	119	12/9/2004	вус			
422	3	12/9/2004	BYC			
422	105	12/9/2004	BYC			
422	82.05	12/9/2004	BYC			
422	56	12/10/2004	BYC			
21	2	12/10/2004	BYC			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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ATE	EXMR
4/2004	вус
9/2004	вус
9/2004	вус
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